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				APPLICANT				
LIST OF	REFE	RENCES CITED BY A	PPLICANT	Takashi KIKUKAWA, et al.				
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				U.S. PATENT DOCUMENTS		•		
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/MB/	AO	EP 1 645 429 A1	4/12/2006	Europe		YES	NO NO	
/MB/	AP	EP 1 646 042 A1	4/12/2006	Europe				
/MB/	AQ	EP 1 640 977 A1	3/29/2006	Europe				
/MB/	AR	EP 1 640 981 A1	3/29/2006	Europe				
/MB/	AS	EP 1 657 717 A1	5/17/2006	Europe				
/MB/	AT	EP 1 643 497 A1	4/5/2006	Europe				
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		OTHER R	EEEDENCES (L	notuding Author Title Date Batter				
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
/MB/	AW	Wei-Chi HSU, et al., "Blue-Laser Readout Properties of Super Resolution Near Field Structure Disc with Inorganic Write-Once Recording Layer", JPN. J. APPL. PHYS, XP002458621, vol. 42, no. part 1, 2B, February 2003, pages 1005-1009						
/MB/	AX	Jooho KIM, et al., "Reactive recording with rare-earth transition metal", APPLIED PHYSICS LETTERS, XP012029161, vol. 79, no. 16, October 15, 2001, pages 2600-2602						
/MB/	AY	Takashi KIKUKAWA, et al., "Recording and Readout Mechanisms of Super Resolution Near-Field Structure Disc with Silver-Oxide Layer", JPN. J. APPL. PHYS., XP002452548, vol. 42, no. 2B, February 2003, pages 1038-1039						
	AZ	☐ Add				ditional References sheet(s) attached		
Examiner /Mark Blouin/					Date Considered 08/07/2008			
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